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Ta₂C precipitation after low pressure carburizing of tantalum

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- This paper presents the first research work about Ta₂C precipitates layer growth.
- Tantalum matrix vacancies are consumed during the precipitation of Ta₂C.
- Ta₂C precipitation is reduced close to vacancy sinks (grain boundary, surface, ...).
- Ta₂C precipitation is also reduced in zones where Ta₂C precipitates had appeared at least once.
- An annealing treatment following a carburizing treatment increase the Ta₂C precipitates layer growth.

A B S T R A C T

Keywords:

Tantalum
Carburizing
Ta₂C
Annealing

Low pressure carburizing cycles were carried out on tantalum samples. A Ta₂C precipitates layer is present under the TaC and Ta₂C surface layers. As the TaC and Ta₂C layers, the Ta₂C precipitates layer (TPL) grows by carbon diffusion in tantalum matrix. Specific zones with low precipitates content were observed at the bulk surface and in the tantalum grain boundaries. Other zones with lower precipitates content are also present in carburized and annealed samples. All the zones with low precipitates content are induced by the Ta₂C precipitation mechanism described by Dahmen et al. [1,2]. Indeed, Ta₂C needs vacancies to precipitate. If vacancy sinks are present at the bulk surface, at a grain boundary or in a dislocation, then Ta₂C precipitation is highly reduced. Another effect of the annealing treatment is an increase of the Ta₂C precipitates layers growth rate.

1. Introduction

Tantalum carbides were highly studied in the 60's for their interesting properties (high melting point, high hardness ...). TaC and Ta₂C carbides can be obtained on tantalum parts by carburizing [1]. First, Ta₂C layer appears at the tantalum surface. Then the supersaturation in carbon of Ta₂C causes a TaC layer at the surface [2]. These carbide layers were obtained by many carburizing processes [3–6]. The diffusion of carbon is the main mechanism that leads to these carbides growth as shown in the literature [3,6,7].

The Ta/C phase diagram, given by Gusev et al. [8] (Fig. 1), shows the range of existence of the two main carbides TaC and Ta₂C. These carbides could exist in a non-stoichiometric form. TaC can contain between 42.5 and 50% at.% carbon. Ta₂C has two allotropic phases, α-Ta₂C

(ordered carbon sublattice, CdI₂ antitype structure) and β-Ta₂C (disordered carbon sublattice, L'3 structure). An allotropic transformation between α and β-Ta₂C occurs at approximately 1677 °C [8–10]. This transformation has been observed by thermal analysis by Rudy et al. [11]. This compound exists for a small concentration range, between 26 and 33.3% at. of carbon and his melting point is 3330 °C [11]. Two other carbides are described in the phase diagram: Ta₄C₃ and Ta₆C₅. Ta₄C₃ was described for the first time by Lesser et al. [7]. It is a rhombohedral carbide (R3m space group) that appears in the presence of TaC and Ta₂C [12]. Ta₆C₅ is an ordered phase created by the order/disorder transition of non-stoichiometric TaC [8]. These two carbides appear after long annealing times.

After a carburizing cycle on tantalum, a strong decrease of the carbon solubility limit causes a carbon saturation during its cooling [12–16],

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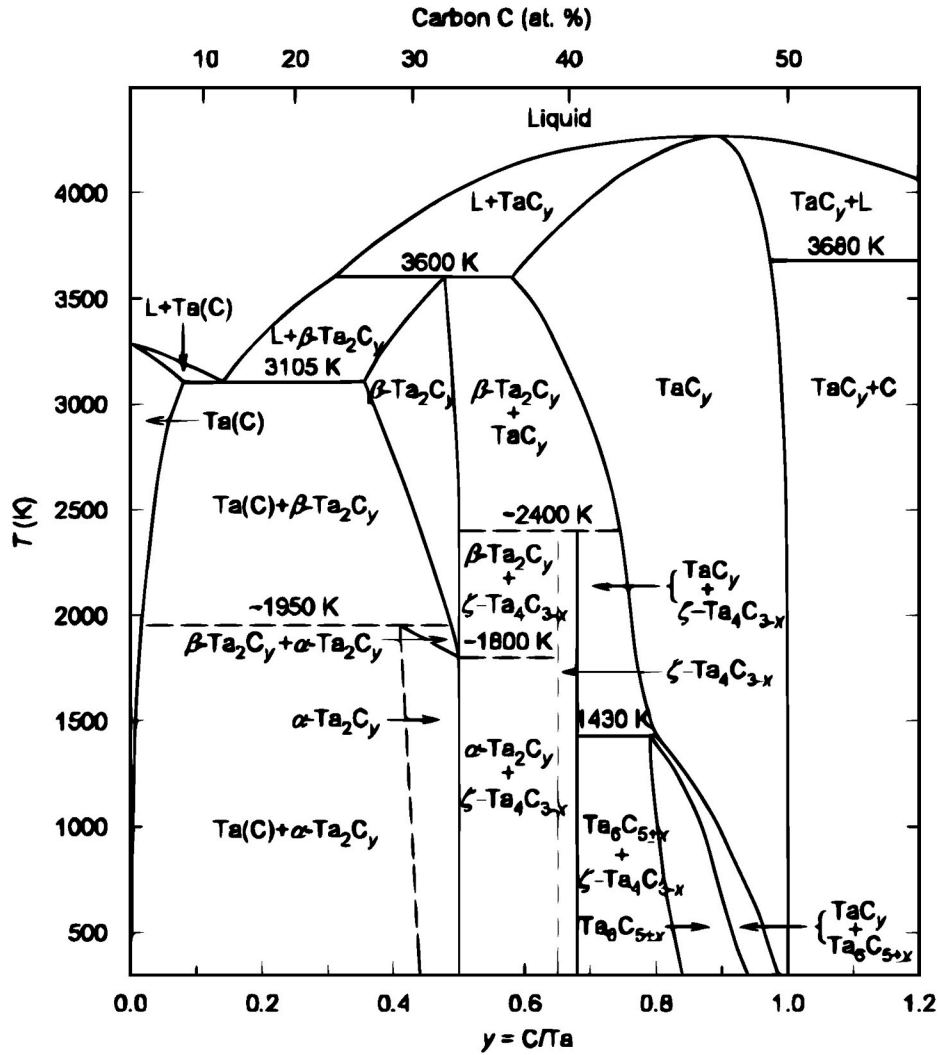


Fig. 1. Ta/C phase diagram [8].

Table 1

Concentration of impurities determined by GDMS.

Element	Na	Mg	Al	Si	S	K	Ti
Wt ppm	<0.01	<0.001	0.25	0.52	<0.005	<0.01	0.003
Element	Cr	Mn	Fe	Pb	Co	Ni	Cu
Wt ppm	0.09	<0.005	1.4	<0.005	<0.001	<0.001	0.14
Element	Zn	Zr	Nb	Mo	C	Ta	W
Wt ppm	<0.005	0.11	36	0.81	<0.05	Matrix	0.25

from 7.5 %at C at 2843 °C [11] to 0.08 %at C at room temperature [13, 16]. Then Ta₂C precipitates appear scattered in the tantalum supersaturated matrix. Ta₂C precipitation was also observed by Rudy et al. [11] with a highly exothermic reaction as evidenced by a DTA-thermogram. Dahmen et al. [17,18] highlight the contribution of vacancies on Ta₂C precipitation. The present study shows that these precipitates could appear as layers under TaC and Ta₂C ones. These carbides layers growth were highly studied in many different processes, and will not be studied in this paper. In the literature dealing with Ta₂C precipitates [11,14, 18–24], they are always described as filling the tantalum matrix, and never as layers under tantalum carbides layers. However, as far as we know, there are no previous studies about Ta₂C precipitates layers growth. The aim of this paper is the characterization of these Ta₂C precipitates and especially of their distribution. Moreover, the influence of parameters such as carburizing and annealing time has been approached.

Table 2

Concentration of impurities determined by IGA.

Element	C	N	O	S	H
wt ppm	<5	20	10	-	4,7

2. Experimental

High purity (99.99%) tantalum samples (10 mm in diameter and 2 mm thick, from a rolled round bar) were used in this study. The chemical composition has been verified by GDMS (Table 1) and IGA (Table 2).

The initial microstructure is composed of various grain sizes, from 1–40 μm, and determined by EBSD, with a TSL EDAX OIM XM detector. Ta₂C precipitates appear during the carburizing treatment of tantalum. The carburizing has been made at low pressure, with a BMicro furnace.

Table 3
Experimental plan.

Carburizing temperature (°C)	1400						1600					
Carburizing time (min)	60	120	240		60		120		240			
Annealing time (min)		0		0	30	60	120	0	30	60	120	

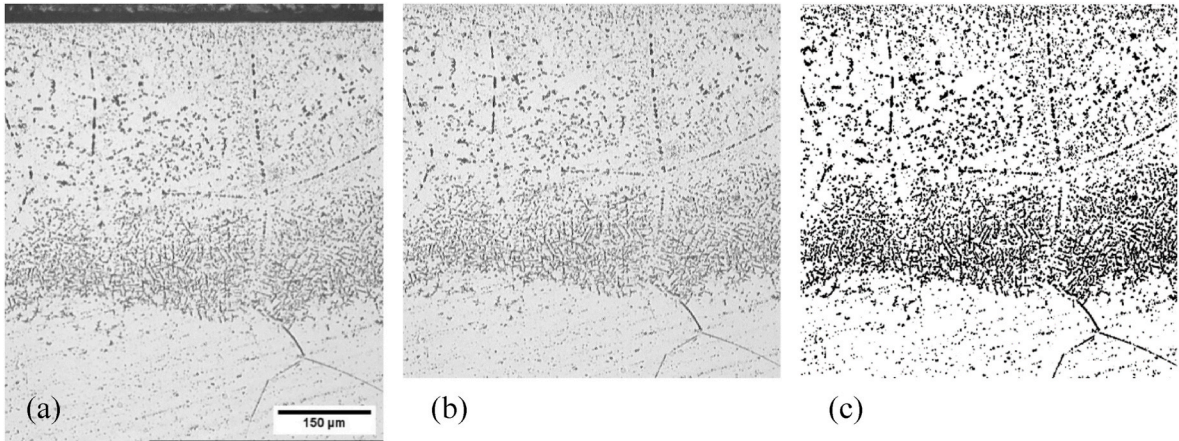


Fig. 2. Optical cross section image of a tantalum sample carburized for 20 min and annealed for 60 min, (a): Original image, (b): Cropped image, (c): Binarized image.

The carburizing treatment involves several steps: primary vacuum in the chamber, heating, carburizing and cooling. The carburizing temperature was reached with a rate of 30 °C/min. The carburizing gas was ethylene (C₂H₄, 99.99% of purity) at a pressure of 20 mbar, with a gas flow rate of 20 L/h. The heating resistors of the furnace and the sample holder was made in graphite. Gas pressure has been measured with a Baratron capacitance gauge for pressures in the range of few mbar, and with a Pirani gauge for pressures in the range of 10⁻² mbar. Two temperatures were investigated (1400 °C and 1600 °C) and three carburizing times

(60, 120 and 240 min). The highest temperature tested here is 1600 °C (1873K), so the Ta₂C carbide formed by precipitation should only be α-Ta₂C (Fig. 1). The temperature in the furnace chamber was controlled by two Type C molybdenum sheathed thermocouples, placed between the resistors and the samples. After the carburizing cycle, samples were cooled under 1 bar of nitrogen. Some carburized samples were then annealed, for 30 min–120 min at 1600 °C. The experimental plan is described in Table 3, each experiment has been carried once, with one tantalum sample in the chamber:

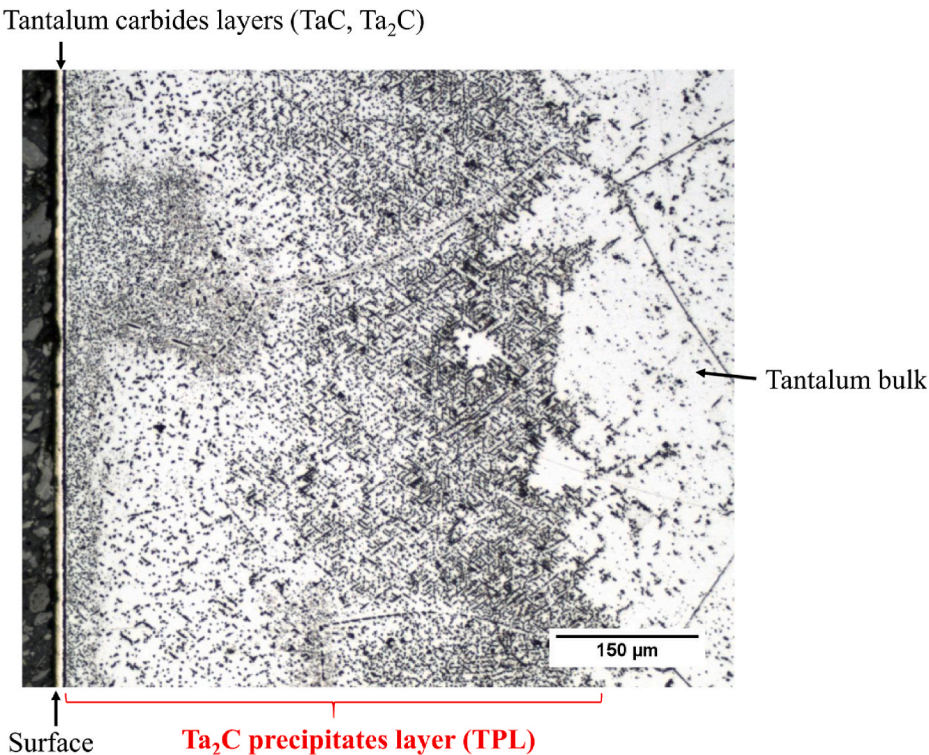


Fig. 3. Optical cross section of a carburized sample: 240 min at 1600 °C (etching HF + HNO₃).

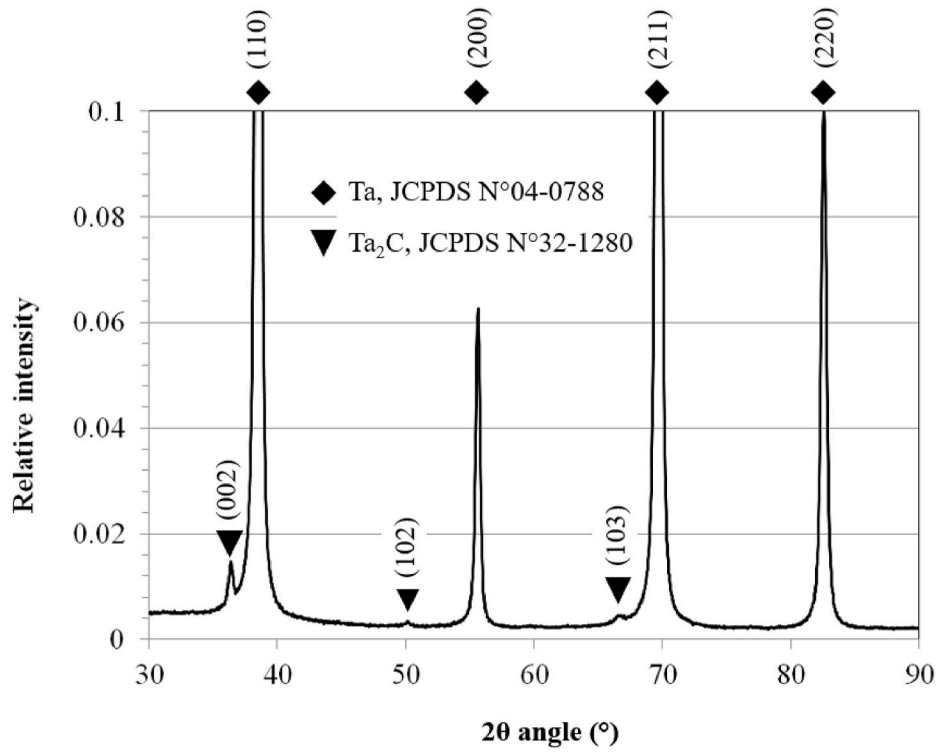


Fig. 4. XRD patterns of a sample carburized 60 min at 1600 °C.

Annealed samples were cooled under primary vacuum ($\sim 10^{-2}$ mbar). After treatments, the samples were cut and cross sections were polished with SiC papers then colloidal silica solution. Ta₂C precipitates were revealed by etching, with a combination of strong acids (13% vol. HF + 23% vol. HNO₃ + 64% vol. H₂O). This etching recipe is derived from the publication of Chang et al. [25].

The Ta₂C precipitates density has been determined from optical images with ImageJ software as shown in Fig. 2. First, images were cropped in order to remove surface carbide layers or artifacts such as the

scale bar. Next, images were binarized with a threshold of 191/255. Black pixels depict Ta₂C precipitates, etching pits and grain boundaries. We assumed that the values found below the Ta₂C precipitates layer are due to etching pits and etched grain boundaries.

Then, the density of pixels was calculated for each row of pixels, from the surface to the bulk material. For each row, the total amount of black pixels is divided by the total number of pixels. Each row of pixel is 0.8 μm thick. Then we obtained a graph representing the Ta₂C precipitates density as a function of the depth observed. Curves were smoothed with

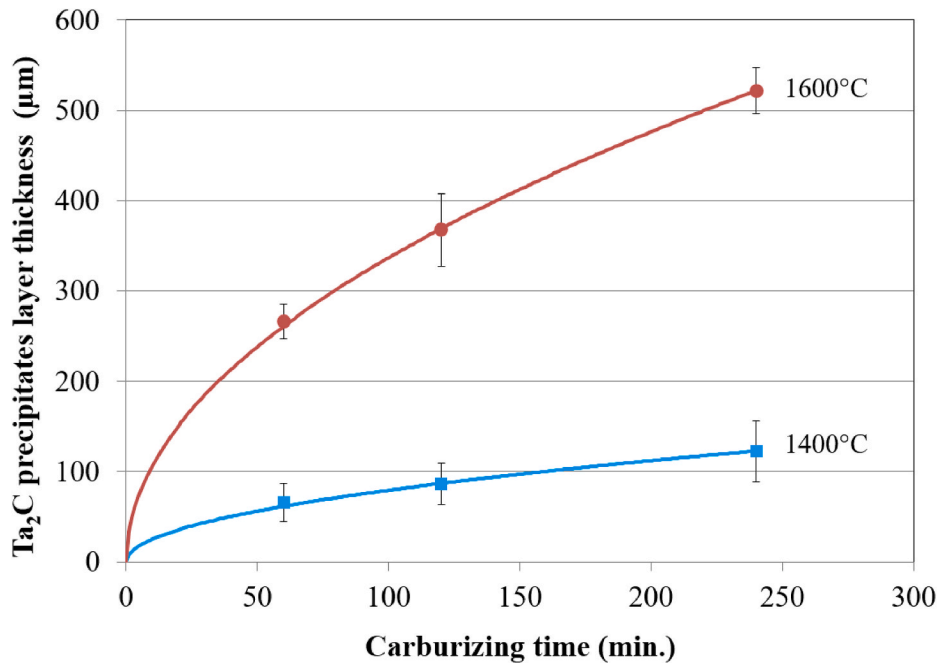


Fig. 5. Ta₂C precipitates layer thickness vs. carburizing time.

Table 4

Growth constants of TPL.

Carburizing temperatures (°C)	Growth constants ($\mu\text{m}^2/\text{s}$)
1400	1.04
1600	18.92

a floating mean calculated with 30 values.

The average thickness of the Ta₂C precipitate layers were measured from three optical images where 20 measurements were carried out. Ta₂C precipitates pictures have been made with an Eclipse L150 microscope. For the need of the publication of this article, other micrographs have been made later with a BM51X microscope (Figs. 3, 7 and 9).

The microstructure of the treated samples was identified by XRD (XRG 3000 Inel diffractometer) using a copper radiation source ($\lambda_{\text{Cu}} = 0.1541 \text{ nm}$) at 40 kV and 40 mA at the source (Bragg-Brentano configuration). The XRD patterns have been compared with JCPDS databases to identify compounds. An acquisition time of 15 h has been necessary to reduce the signal/noise ratio, in order to get Ta₂C peaks on the XRD patterns.

Vickers hardness indentations were made using a BUEHLER 1600–6300 microhardness tester with a 100 g load.

3. Results and discussion

3.1. Carburizing of tantalum samples

Fig. 3 shows an optical cross section image of the Ta₂C precipitates layer (TPL) which appears under carbides layers. The region between tantalum bulk and the precipitates is irregular but well defined.

In order to identify the nature of the precipitates, XRD analysis was carried out on a carburized sample (60 min at 1600 °C). The surface of the sample was previously polished to remove carbide layers. Three Vickers indentations measured before and after polishing the sample were used to determine the thickness of the removed metal that was $505 \pm 50 \mu\text{m}$.

Only two compounds were identified on the XRD patterns (Fig. 4): one can note the diffraction peaks characteristic of the tantalum substrate and only three diffraction peaks characteristic of Ta₂C. The theoretical main diffraction peak of Ta₂C (101) located at 44.5° can't be detected as it is superimposed with the Ta (100) one. Therefore, it is not

possible to calculate the exact amount of Ta₂C. Nevertheless, as the Ta₂C peaks intensities are very low compared to the Ta ones, we expect a low amount of Ta₂C in the Ta matrix.

The Ta₂C precipitates layers thickness as a function of the carburizing time is reported in Fig. 5.

These measurements were fitted by a parabolic law for each carburizing temperature. This law can be expressed by the usual equation (1) [3–6]:

$$W = \sqrt{kt} \quad (1)$$

where W is the precipitates layer thickness (μm), k is a growth constant (temperature dependent, $\mu\text{m}^2/\text{s}$) and t is the carburizing time (s).

The obtained curves confirm that the TPL growth is driven by carbon diffusion in tantalum as reported by Kidson [26]. The growth constants, k , were determined from equation (1) and Fig. 4 and are reported in Table 4.

These growth constants are higher than TaC and Ta₂C growth constants. For example, Rocher [2] showed growth constants of $7.56 \times 10^{-4} \mu\text{m}^2/\text{s}$ and $3.28 \times 10^{-3} \mu\text{m}^2/\text{s}$ for TaC layer growth, respectively at 1400 °C and 1600 °C. This is probably due to a higher carbon diffusion coefficient, 4 order of magnitude higher in tantalum than in TaC or Ta₂C [3,6,13].

Ta₂C precipitates optical images also showed (Fig. 3) an irregular region between the TPL and tantalum matrix, which induced non accurate TPL thickness measurements. These thickness variations are located inside and at grain boundaries, and could be explained by an increased carbon diffusion coefficient. It has been observed in the case of other diffusion couples such as carbon/niobium [27]. Then we could expect that some crystalline defects, like grain boundaries or subgrain boundaries could influence carbon diffusion coefficient in tantalum.

The density of Ta₂C precipitates were measured on carburized tantalum samples (Fig. 6). The three measurements were carried out at different locations of the surface sample and permitted to verify the reproducibility of the measurements. The density is not homogeneous in the bulk of the sample: it varies from 65% near the surface from 27% at 200 μm of depth (zone A). Then, the density reaches 65% at 450 μm of depth (zone B) and finally decreases (zone C) and remains constant (15%) in the bulk of the sample (zone D). The 15% constant level depicts the density of etching pits due to the chemical etching on tantalum.

The density of precipitates is driven by the mechanism reported by Dahmen et al. [17,18] and Westmacott [28]. Ta₂C precipitates need vacancies to appear during the cooling stage after the carburizing.

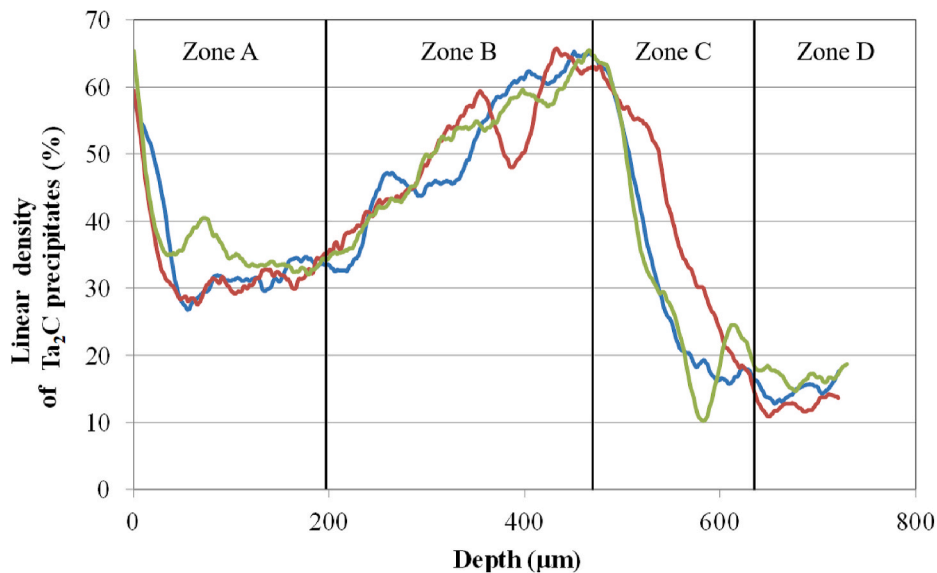


Fig. 6. Linear density of Ta₂C precipitates for a carburized sample during 240 min at 1600 °C.

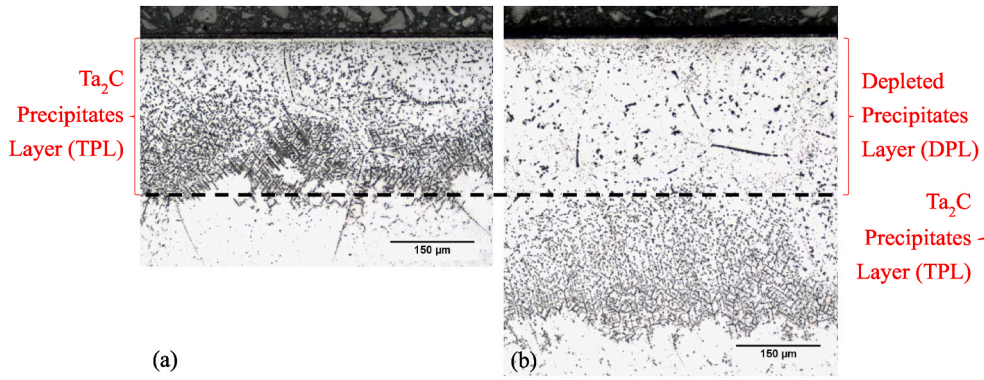


Fig. 7. Optical cross section images: of a carburized sample during 1h at 1600 °C(a) and of a carburized (1h/1600 °C) and annealed (1h/1600 °C) sample (b).

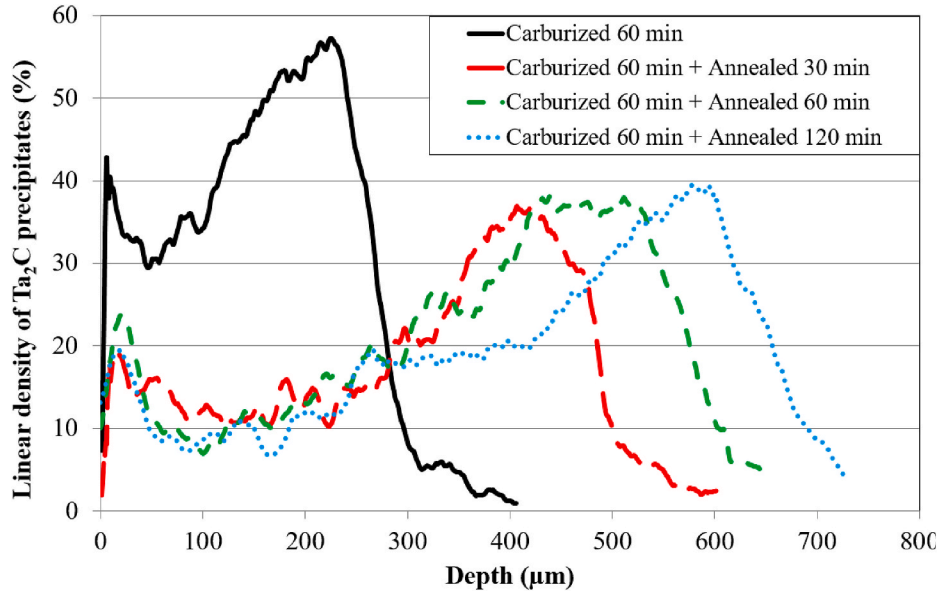


Fig. 8. Linear density of Ta₂C precipitates for a carburized and carburized + annealed sample.

During this cooling stage, carbon solubility in tantalum decreases, resulting in carbon atoms still in solid solution. When the carbon concentration reaches its limit of solubility in Ta, the carbon atoms diffuse towards the surrounding vacancies. Vacancy-carbon atom complexes align themselves on {310} tantalum planes, to form Ta₂C coherent platelets. During their growth the Ta₂C precipitates become progressively incoherent but keep their crystalline orientations. Indeed, during the precipitates formation, vacancies disappear by local collapse of the tantalum lattice. bulk surface, dislocations and grain boundaries are vacancy sinks [28]. Therefore Ta₂C precipitation is reduced near these lattice defaults. The low value of precipitates density in the zone A could be probably due to the diffusion of vacancies to the bulk surface. Concerning the high value of precipitates density in the first 50 μm of depth, it remains yet unexplained.

3.2. Annealing of the carburized tantalum samples

3.2.1. Ta₂C precipitates distribution in the TPL

The annealing treatment changes the Ta₂C precipitates distribution in the TPL (Fig. 6).

As shown in Fig. 7a) and b), the Ta₂C precipitates thickness increases from 266 μm to 543 μm after annealing at 1600 °C during 60 min. A new region with a low amount of precipitates appears after annealing (region DPL, for Depleted Precipitates Layer). It is obvious that the thickness of

the TPL before annealing corresponds exactly to the thickness of this new region.

The thicker TPL after annealing is probably due to carbon diffusion. Indeed, during the annealing treatment, the increasing of the limit of solubility of carbon in Ta produced the dissolution of the Ta₂C precipitates. The carbon in solid solution has then diffused in the bulk of the sample. The TaC and Ta₂C carbide layers at the surface also supplied carbon to the tantalum substrate by diffusion.

The Ta₂C precipitates in the bulk surface of the annealed sample are probably due to the co-precipitation of Ta₂C [18]. Indeed, after the first carburizing treatment, the Ta₂C precipitates are produced at the cooling stage from the supersaturated solution of carbon in tantalum. Then, vacancies initially existing in tantalum are consumed during the precipitation of Ta₂C. The annealing treatment is then carried out, allowing the carbon to diffuse deeper into tantalum. During the cooling stage of the annealing treatment, Ta₂C precipitates appear in the remaining vacancies under the previous TPL. In the DPL region, the vacancies did not reappear during the annealing treatment preventing Ta₂C precipitation.

Measurements of precipitates density were carried out on carburized and annealed samples (Fig. 8) for different annealing times. The annealing time has no effect on the precipitates density near the surface sample where the amount of Ta₂C precipitates is relatively low (~10% in region DPL). One can note that it corresponds to the higher Ta₂C precipitates content in the case of the only carburized sample. This result

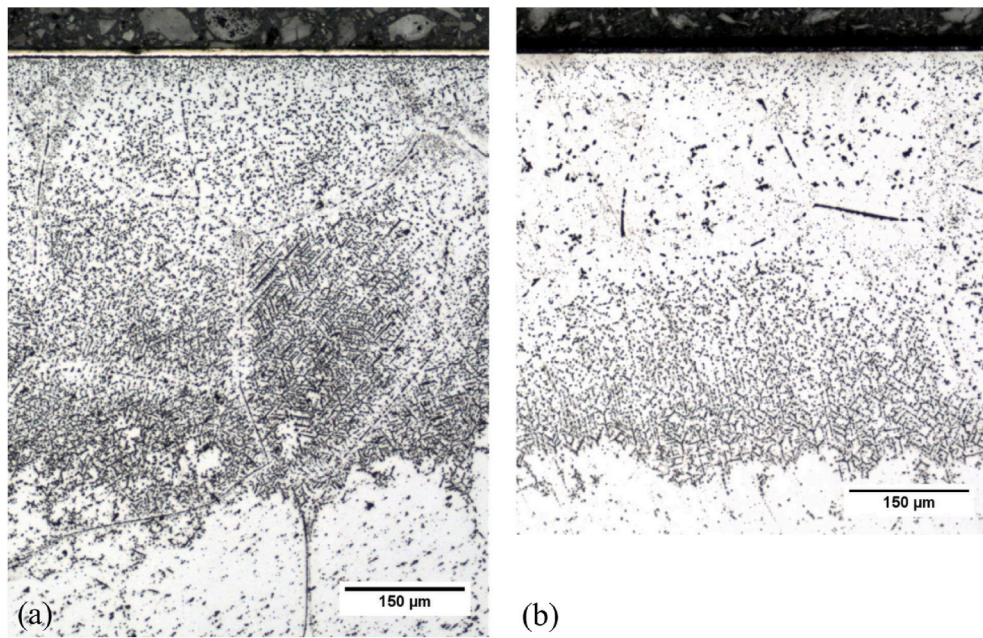


Fig. 9. Optical cross section images of Ta_2C precipitates layers in, (a) a carburized sample 240 min/1600 °C, (b) a carburized 60 min + annealed 60 min/1600 °C sample.

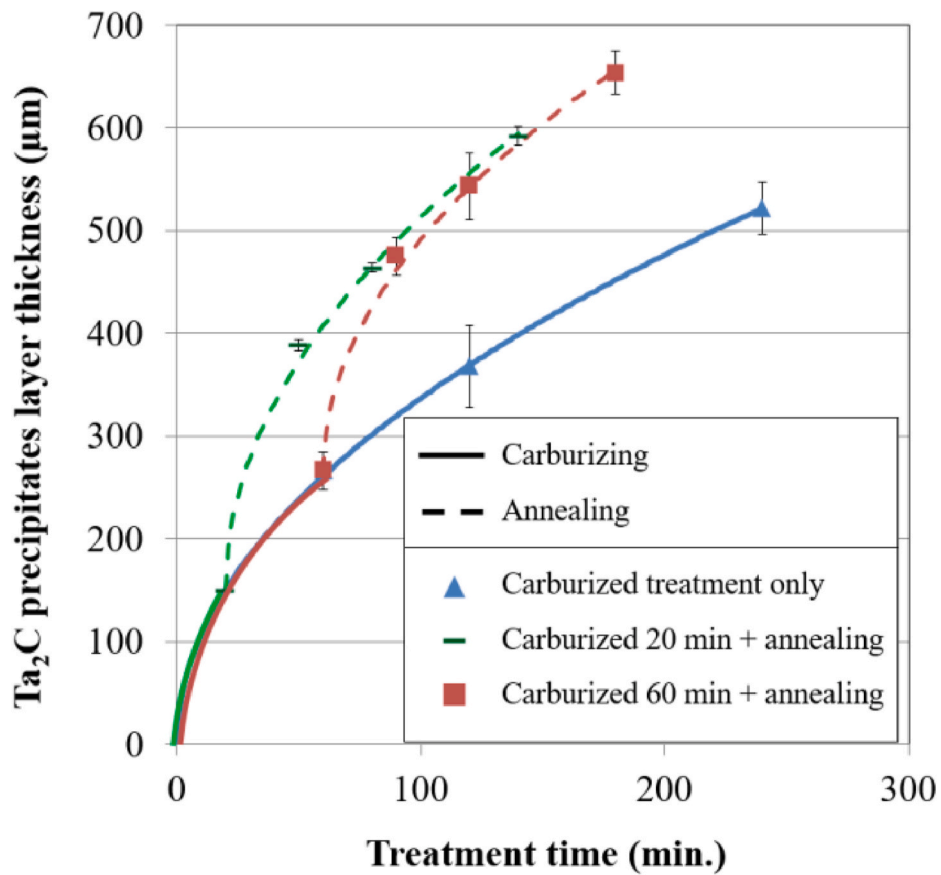


Fig. 10. Ta_2C precipitates layer thickness vs. treatment time for carburized and carburized + annealed samples.

confirms that the initial TPL has an influence on the TPL generated after the annealing treatment. Fig. 7 shows obviously that the annealing time has an influence on the higher Ta_2C precipitates depth location (from 400 to 600 μm) and density (from 37 to ~40%) as annealing time varied

from 30 to 240 min. The increasing Ta_2C precipitates depth location is due to the diffusion of carbon in the tantalum bulk.

Table 5

Growth constants computed from parabolic growth of TPL.

	Growth constants ($\mu\text{m}^2/\text{s}$)
Only carburized	18.9
Carburized 20 min + annealing	27.4
Carburized 60 min + annealing	21.1

3.2.2. Ta_2C precipitates growth in the TPL

The nature of the treatment changes the growth of the Ta_2C precipitates in the TPL. Fig. 9 a) shows a TPL produced after a carburizing of 240 min at 1600 °C while Fig. 9 b) shows a TPL produced after a carburizing of 60 min at 1600 °C followed by an annealing of 60 min at 1600 °C. As the thickness of both TPL is similar, it is therefore possible that the annealing treatment increases the TPL growth rate.

In order to understand why an increase of the TPL growth rate occurred during the annealing treatment, the TPL thicknesses were measured on carburized and annealed samples. As mentioned above in paragraph 3.1, the TPL growth kinetic follows a parabolic law as shown in Fig. 10. It is also obvious in Fig. 10 that the annealing treatment accelerate the TPL growth kinetics. The TPL growth kinetics is also described by parabolic laws converging whatever the initial carburizing time.

It is noteworthy in Fig. 9 that the parabolic curve representing the Ta_2C precipitates is reinitialized at the beginning of the annealing treatment causing an increase of the TPL growth kinetics. The corresponding growth constants were measured on the parabolic parts of the different curves of Fig. 9 and reported in Table 5.

An annealing treatment carried out after a carburizing one induced an increase of the TPL growth constants. Besides, the higher the initial carburizing time, the lower is the growth constant.

To explain the above results, we suggest that two phenomena occurred: the first one is the Ta_2C precipitation (during the carburizing cycle) and the second one is the diffusion of carbon into the tantalum matrix. Indeed, the parabolic growth of the TPL is due to the decrease of the carbon flux during a carburizing cycle. According to the first Fick's Law (equation (2)), the carbon flux between two points is driven by three parameters: the carbon diffusion coefficient, the gradient of concentration and the distance between these two points.

$$J = -D \frac{dC}{dx} \quad (2)$$

where D is the diffusion coefficient, C is the concentration of species and x is the distance.

If we have a carbon unsaturated tantalum matrix, the carbon concentration is assumed to be comprised between 0 and its limit of

solubility in tantalum at the carburizing temperature [29]. When the carbon diffuses into tantalum, its diffusion coefficient is supposed to be constant. Then, if the sample is carbon unsaturated, the difference between the lowest and the highest carbon concentration is constant. That is why the parabolic growth of TPL can only be explained by the increasing distance between the two extreme carbon concentrations in the tantalum.

At the beginning of the carburizing cycle, the carbon flux is high because of the significant gradient of carbon concentration between the tantalum matrix and carbides layers at the tantalum surface. The increasing carbon concentration in the tantalum induces a decreased carbon flux. The TPL growth is then slow down, as a parabolic law. Therefore, the TPL growth rate involves an increased carbon flux in the tantalum. This growth rate would take place during the annealing treatment. Fig. 11 shows an outline of the carbon concentration evolution, before (Fig. 11 a) and after (Fig. 11 b) the cooling stage of the carburizing cycle. These curves are deduced from the literature [11,13,24].

During the cooling stage, the decrease of the temperature causes the decrease of the limit of solubility of the carbon in the tantalum, which induces Ta_2C precipitation. After cooling, the carbon concentration is equal to its limit of solubility at room temperature, which is very low and estimated to $5.10^{-3} \% \text{ wt}$ [13]. At the beginning of the annealing treatment, the limit of solubility of the carbon in the tantalum increases with the temperature. One can suppose that precipitates do not immediately dissolve with the increasing of carbon solubility limit. Simultaneously, the carbon concentration in the tantalum matrix is still low. Therefore, there is a significant concentration gradient between the tantalum matrix and the carbide layers, increasing the carbon flux in the tantalum matrix. This hypothesis would explain the growth rate increase noticed at the beginning of the annealing treatment. This phenomenon has been also noticed in the literature, with the carburizing of tantalum-tungsten alloy [30].

A convergence of kinetic laws of TPL was noticed in Fig. 10. TPL growth is faster for an initial 20 min carburizing treatment than for a 60 min one. This can be explained by the carbon concentration gradient, higher for 20 min of carburizing than for 60 min.

4. Conclusions

In one hand, series of tantalum carburizing has been carried out by low pressure carburizing under ethylene. Optical cross section images have shown that a TPL is obtained, in addition to the TaC and Ta_2C surface layers. This TPL is induced by the precipitation of supersaturated carbon in tantalum during the cooling stage of the carburizing cycle. The TPL thickness measurements have shown a parabolic evolution as a

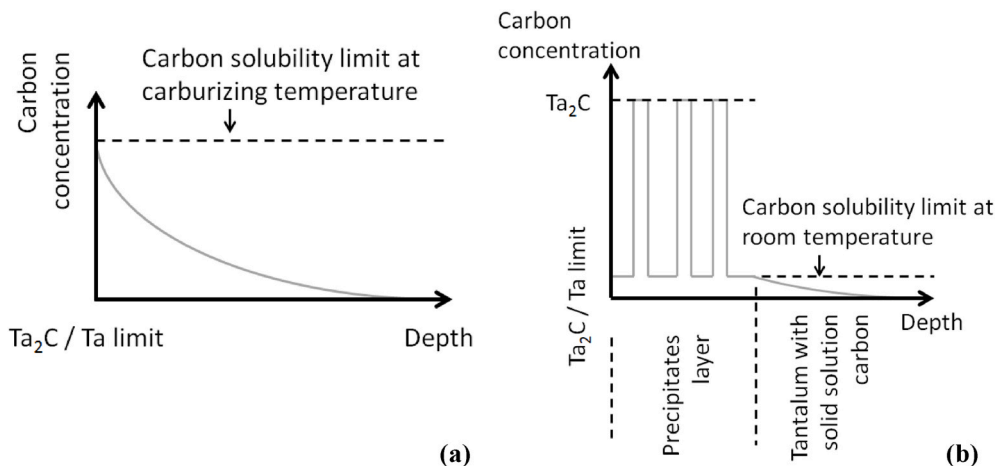


Fig. 11. Carbon concentration in tantalum, (a) during a carburizing treatment, (b) after the cooling stage.

function of the carburizing time. This indicates that TPL growth kinetic is driven by carbon diffusion. The Ta₂C precipitation mechanism, described by Dahmen et al. [18], fits well with the observations carried out by optical microscopy. The Ta₂C needs close vacancies to precipitate. Then, if vacancy sinks are at the bulk surface, in a grain boundary or in a dislocation, then the Ta₂C precipitation is highly reduced.

In the other hand, annealing treatments were carried out on carburized samples. The first significant effect of annealing treatments on TPL is the appearance of an almost precipitates free zone near the bulk surface. When the carburized and carburized + annealed samples were compared, it was shown that new Ta₂C precipitates did not form where a previous Ta₂C precipitation occurred. This phenomenon is also explained by Dahmen's mechanism [18]. The vacancies are filled during the first precipitation occurring after the first carburizing cycle. At the end of the annealing treatment, the carbon has diffused deeper in the tantalum. Then, the Ta₂C precipitation is inhibited where the new TPL appeared, and occurred deeper in the tantalum matrix where vacancies are still present. The second significant effect of the annealing treatment is an increase of the TPL growth rate. This was explained by a carbon flux variation, due to the intermediate precipitation of Ta₂C between the carburizing and the annealing treatment. This mechanism needs to be confirmed with additional studies.

Dominique Cotton: Investigation, Conceptualization, Methodology, Writing – original draft, Data curation, Formal analysis. **Philippe Jacquet:** Supervision, Writing – review & editing, Resources, Funding acquisition. **Sébastien Faure:** Supervision, Funding acquisition, Writing – review & editing. **Vincent Vignal:** Supervision, Writing – review & editing, Resources, Funding acquisition, Project administration.

The authors declare that they have no known competing financial interests or personal relationships that could have appeared to influence the work reported in this paper.

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